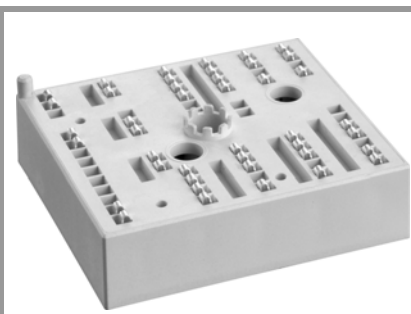


# SKiiP 24ACC12T4V10



MiniSKiiP® 2

## Twin 6-pack

### SKiiP 24ACC12T4V10

#### Features\*

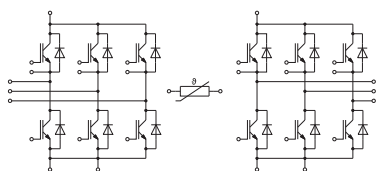
- Trench 4 IGBTs
- Robust and soft switching freewheeling diodes in CAL technology
- Highly reliable spring contacts for electrical connections
- UL recognized: File no. E63532

#### Typical Applications

- 4Q inverters

#### Remarks

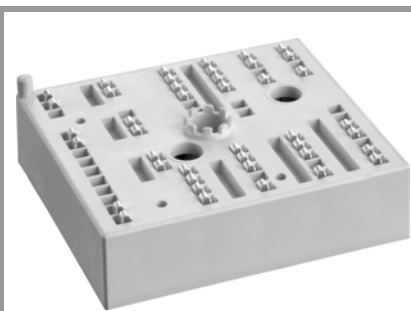
- Max. case temperature limited to  $T_C=125^\circ\text{C}$
- Product reliability results valid for  $T_j \leq 150^\circ\text{C}$  (recommended  $T_{j,op} = -40 \dots +150^\circ\text{C}$ )
- Terminal distances sufficient for basic insulation in 3-phase 480VAC TN systems
- DC-link voltage  $V_{DC} \leq 800\text{V}$
- Temperature sensor: no basic insulation to main circuit, signal processing with reference to -DC potential
- Please refer to MiniSKiiP "Technical Explanations" and "Mounting Instructions" for further information



ACC

Absolute Maximum Ratings				
Symbol	Conditions		Values	Unit
IGBT 1 - 6				
V <sub>CES</sub>	T <sub>j</sub> = 25 °C		1200	V
I <sub>C</sub>	λ <sub>paste</sub> =0.8 W/(mK)	T <sub>s</sub> = 25 °C	41	A
	T <sub>j</sub> = 175 °C	T <sub>s</sub> = 70 °C	34	A
I <sub>C</sub>	λ <sub>paste</sub> =2.5 W/(mK)	T <sub>s</sub> = 25 °C	45	A
	T <sub>j</sub> = 175 °C	T <sub>s</sub> = 70 °C	37	A
I <sub>Cnom</sub>			25	A
I <sub>CRM</sub>			75	A
V <sub>GES</sub>			-20 ... 20	V
t <sub>psc</sub>	V <sub>CC</sub> = 800 V V <sub>GE</sub> ≤ 15 V V <sub>CES</sub> ≤ 1200 V	T <sub>j</sub> = 150 °C	10	μs
T <sub>j</sub>			-40 ... 175	°C
IGBT 7 - 12				
V <sub>CES</sub>	T <sub>j</sub> = 25 °C		1200	V
I <sub>C</sub>	λ <sub>paste</sub> =0.8 W/(mK)	T <sub>s</sub> = 25 °C	52	A
	T <sub>j</sub> = 175 °C	T <sub>s</sub> = 70 °C	43	A
I <sub>C</sub>	λ <sub>paste</sub> =2.5 W/(mK)	T <sub>s</sub> = 25 °C	58	A
	T <sub>j</sub> = 175 °C	T <sub>s</sub> = 70 °C	48	A
I <sub>Cnom</sub>			35	A
I <sub>CRM</sub>			105	A
V <sub>GES</sub>			-20 ... 20	V
t <sub>psc</sub>	V <sub>CC</sub> = 800 V V <sub>GE</sub> ≤ 15 V V <sub>CES</sub> ≤ 1200 V	T <sub>j</sub> = 150 °C	10	μs
T <sub>j</sub>			-40 ... 175	°C
Diode 1 - 6				
V <sub>RRM</sub>	T <sub>j</sub> = 25 °C		1200	V
I <sub>F</sub>	λ <sub>paste</sub> =0.8 W/(mK)	T <sub>s</sub> = 25 °C	32	A
	T <sub>j</sub> = 175 °C	T <sub>s</sub> = 70 °C	26	A
I <sub>F</sub>	λ <sub>paste</sub> =2.5 W/(mK)	T <sub>s</sub> = 25 °C	35	A
	T <sub>j</sub> = 175 °C	T <sub>s</sub> = 70 °C	28	A
I <sub>FRM</sub>			50	A
I <sub>FSM</sub>	10 ms, sin 180°, T <sub>j</sub> = 150 °C		100	A
T <sub>j</sub>			-40 ... 175	°C
Diode 7 - 12				
V <sub>RRM</sub>	T <sub>j</sub> = 25 °C		1200	V
I <sub>F</sub>	λ <sub>paste</sub> =0.8 W/(mK)	T <sub>s</sub> = 25 °C	44	A
	T <sub>j</sub> = 175 °C	T <sub>s</sub> = 70 °C	35	A
I <sub>F</sub>	λ <sub>paste</sub> =2.5 W/(mK)	T <sub>s</sub> = 25 °C	49	A
	T <sub>j</sub> = 175 °C	T <sub>s</sub> = 70 °C	40	A
I <sub>FRM</sub>			70	A
I <sub>FSM</sub>	10 ms, sin 180°, T <sub>j</sub> = 150 °C		170	A
T <sub>j</sub>			-40 ... 175	°C
Module				
I <sub>t(RMS)</sub>	20 A per spring		40	A
T <sub>stg</sub>	module without TIM		-40 ... 125	°C
V <sub>isol</sub>	AC sinus 50 Hz, 1 min		2500	V

# SKiiP 24ACC12T4V10



MiniSKiiP® 2

## Twin 6-pack

### SKiiP 24ACC12T4V10

#### Features\*

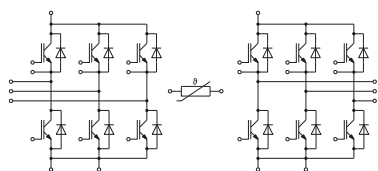
- Trench 4 IGBTs
- Robust and soft switching freewheeling diodes in CAL technology
- Highly reliable spring contacts for electrical connections
- UL recognized: File no. E63532

#### Typical Applications

- 4Q inverters

#### Remarks

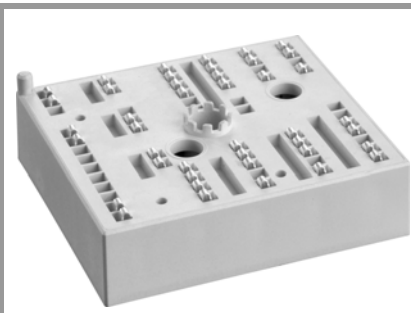
- Max. case temperature limited to  $T_C=125^\circ\text{C}$
- Product reliability results valid for  $T_j \leq 150^\circ\text{C}$  (recommended  $T_{j,op} = -40 \dots +150^\circ\text{C}$ )
- Terminal distances sufficient for basic insulation in 3-phase 480VAC TN systems
- DC-link voltage  $V_{DC} \leq 800\text{V}$
- Temperature sensor: no basic insulation to main circuit, signal processing with reference to -DC potential
- Please refer to MiniSKiiP "Technical Explanations" and "Mounting Instructions" for further information



ACC

Characteristics						
Symbol	Conditions		min.	typ.	max.	Unit
IGBT 1 - 6						
V <sub>CE(sat)</sub>	I <sub>C</sub> = 25 A	T <sub>j</sub> = 25 °C		1.85	2.10	V
	V <sub>GE</sub> = 15 V chiplevel	T <sub>j</sub> = 150 °C		2.25	2.45	V
V <sub>CE0</sub>	chiplevel	T <sub>j</sub> = 25 °C		0.80	0.90	V
		T <sub>j</sub> = 150 °C		0.70	0.80	V
r <sub>CE</sub>	V <sub>GE</sub> = 15 V chiplevel	T <sub>j</sub> = 25 °C		42	48	mΩ
		T <sub>j</sub> = 150 °C		62	66	mΩ
V <sub>GE(th)</sub>	V <sub>GE</sub> = V <sub>CE</sub> V, I <sub>C</sub> = 1 mA		5.3	5.8	6.3	V
I <sub>CES</sub>	V <sub>GE</sub> = 0 V	T <sub>j</sub> = 25 °C			1	mA
	V <sub>CE</sub> = 1200 V					mA
C <sub>ies</sub>	V <sub>CE</sub> = 25 V V <sub>GE</sub> = 0 V	f = 1 MHz		1.45		nF
C <sub>oes</sub>		f = 1 MHz		0.12		nF
C <sub>res</sub>		f = 1 MHz		0.05		nF
Q <sub>G</sub>	V <sub>GE</sub> = - 8 V...+ 15 V			142		nC
R <sub>Gint</sub>	T <sub>j</sub> = 25 °C			0		Ω
t <sub>d(on)</sub>	V <sub>CC</sub> = 600 V	T <sub>j</sub> = 150 °C		96		ns
t <sub>r</sub>	I <sub>C</sub> = 25 A	T <sub>j</sub> = 150 °C		80		ns
E <sub>on</sub>	R <sub>G on</sub> = 39 Ω	T <sub>j</sub> = 150 °C		4.2		mJ
t <sub>d(off)</sub>	R <sub>G off</sub> = 39 Ω	T <sub>j</sub> = 150 °C		400		ns
t <sub>f</sub>	di/dt <sub>on</sub> = 250 A/μs	T <sub>j</sub> = 150 °C		51		ns
E <sub>off</sub>	di/dt <sub>off</sub> = 400 A/μs dv/dt = 3600 V/μs V <sub>GE</sub> = +15/-15 V L <sub>s</sub> = 22 nH	T <sub>j</sub> = 150 °C		2.6		mJ
R <sub>th(j-s)</sub>	per IGBT, λ <sub>paste</sub> =0.8 W/(mK)			1		K/W
R <sub>th(j-s)</sub>	per IGBT, λ <sub>paste</sub> =2.5 W/(mK)			0.84		K/W
IGBT 7 - 12						
V <sub>CE(sat)</sub>	I <sub>C</sub> = 35 A	T <sub>j</sub> = 25 °C		1.85	2.10	V
	V <sub>GE</sub> = 15 V chiplevel	T <sub>j</sub> = 150 °C		2.25	2.45	V
V <sub>CE0</sub>	chiplevel	T <sub>j</sub> = 25 °C		0.80	0.90	V
		T <sub>j</sub> = 150 °C		0.70	0.80	V
r <sub>CE</sub>	V <sub>GE</sub> = 15 V chiplevel	T <sub>j</sub> = 25 °C		30	34	mΩ
		T <sub>j</sub> = 150 °C		44	47	mΩ
V <sub>GE(th)</sub>	V <sub>GE</sub> = V <sub>CE</sub> V, I <sub>C</sub> = 1 mA		5	5.8	6.5	V
I <sub>CES</sub>	V <sub>GE</sub> = 0 V	T <sub>j</sub> = 25 °C			1	mA
	V <sub>CE</sub> = 1200 V			-		mA
C <sub>ies</sub>	V <sub>CE</sub> = 25 V V <sub>GE</sub> = 0 V	f = 1 MHz		1.95		nF
C <sub>oes</sub>		f = 1 MHz		0.16		nF
C <sub>res</sub>		f = 1 MHz		0.12		nF
Q <sub>G</sub>	V <sub>GE</sub> = - 8 V...+ 15 V			200		nC
R <sub>Gint</sub>	T <sub>j</sub> = 25 °C			0		Ω
t <sub>d(on)</sub>	V <sub>CC</sub> = 600 V	T <sub>j</sub> = 150 °C		52		ns
t <sub>r</sub>	I <sub>C</sub> = 35 A	T <sub>j</sub> = 150 °C		34		ns
E <sub>on</sub>	R <sub>G on</sub> = 16 Ω	T <sub>j</sub> = 150 °C		3.9		mJ
t <sub>d(off)</sub>	R <sub>G off</sub> = 16 Ω	T <sub>j</sub> = 150 °C		337		ns
t <sub>f</sub>	di/dt <sub>on</sub> = 680 A/μs	T <sub>j</sub> = 150 °C		53		ns
E <sub>off</sub>	di/dt <sub>off</sub> = 560 A/μs dv/dt = 4000 V/μs V <sub>GE</sub> = +15/-15 V L <sub>s</sub> = 22 nH	T <sub>j</sub> = 150 °C		3.5		mJ
R <sub>th(j-s)</sub>	per IGBT, λ <sub>paste</sub> =0.8 W/(mK)			0.85		K/W
R <sub>th(j-s)</sub>	per IGBT, λ <sub>paste</sub> =2.5 W/(mK)			0.7		K/W

# SKiiP 24ACC12T4V10



MiniSKiiP® 2

## Twin 6-pack

### SKiiP 24ACC12T4V10

#### Features\*

- Trench 4 IGBTs
- Robust and soft switching freewheeling diodes in CAL technology
- Highly reliable spring contacts for electrical connections
- UL recognized: File no. E63532

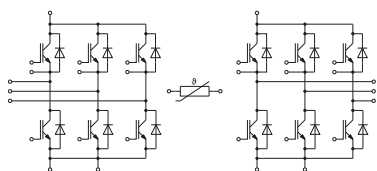
#### Typical Applications

- 4Q inverters

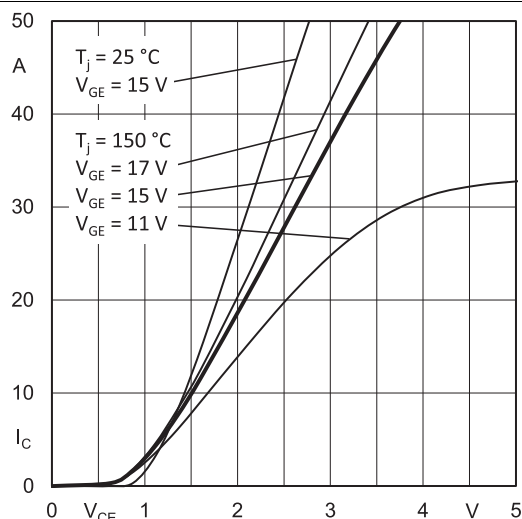
#### Remarks

- Max. case temperature limited to  $T_C=125^\circ\text{C}$
- Product reliability results valid for  $T_j \leq 150^\circ\text{C}$  (recommended  $T_{j,op} = -40 \dots +150^\circ\text{C}$ )
- Terminal distances sufficient for basic insulation in 3-phase 480VAC TN systems
- DC-link voltage  $V_{DC} \leq 800\text{V}$
- Temperature sensor: no basic insulation to main circuit, signal processing with reference to -DC potential
- Please refer to MiniSKiiP "Technical Explanations" and "Mounting Instructions" for further information

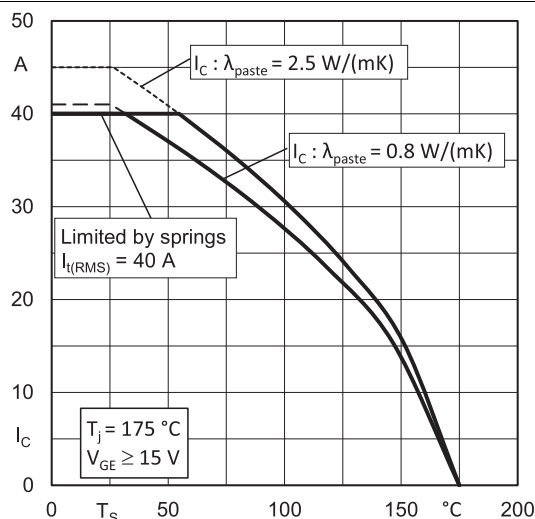
Characteristics					
Symbol	Conditions		min.	typ.	max. Unit
<b>Diode 1 - 6</b>					
$V_F = V_{EC}$	$I_F = 25\text{ A}$ $V_{GE} = 0\text{ V}$ chipelevel	$T_j = 25^\circ\text{C}$		2.41	2.74 V
		$T_j = 150^\circ\text{C}$		2.45	2.79 V
$V_{F0}$	chipelevel	$T_j = 25^\circ\text{C}$		1.30	1.50 V
		$T_j = 150^\circ\text{C}$		0.90	1.10 V
$r_F$	chipelevel	$T_j = 25^\circ\text{C}$		44	50 mΩ
		$T_j = 150^\circ\text{C}$		62	68 mΩ
$I_{RRM}$	$I_F = 25\text{ A}$	$T_j = 150^\circ\text{C}$		17	A
$Q_{rr}$	$di/dt_{off} = 380\text{ A}/\mu\text{s}$ $V_{GE} = -15\text{ V}$	$T_j = 150^\circ\text{C}$		4	μC
$E_{rr}$	$V_{CC} = 600\text{ V}$	$T_j = 150^\circ\text{C}$		1.4	mJ
$R_{th(j-s)}$	per Diode, $\lambda_{paste}=0.8\text{ W}/(\text{mK})$			1.52	K/W
$R_{th(j-s)}$	per Diode, $\lambda_{paste}=2.5\text{ W}/(\text{mK})$			1.31	K/W
<b>Diode 7 - 12</b>					
$V_F = V_{EC}$	$I_F = 35\text{ A}$ $V_{GE} = 0\text{ V}$ chipelevel	$T_j = 25^\circ\text{C}$		2.30	2.62 V
		$T_j = 150^\circ\text{C}$		2.29	2.62 V
$V_{F0}$	chipelevel	$T_j = 25^\circ\text{C}$		1.30	1.50 V
		$T_j = 150^\circ\text{C}$		0.90	1.10 V
$r_F$	chipelevel	$T_j = 25^\circ\text{C}$		29	32 mΩ
		$T_j = 150^\circ\text{C}$		40	43 mΩ
$I_{RRM}$	$I_F = 35\text{ A}$	$T_j = 150^\circ\text{C}$		28	A
$Q_{rr}$	$di/dt_{off} = 720\text{ A}/\mu\text{s}$ $V_{GE} = -15\text{ V}$	$T_j = 150^\circ\text{C}$		5.8	μC
$E_{rr}$	$V_{CC} = 600\text{ V}$	$T_j = 150^\circ\text{C}$		2.3	mJ
$R_{th(j-s)}$	per Diode, $\lambda_{paste}=0.8\text{ W}/(\text{mK})$			1.2	K/W
$R_{th(j-s)}$	per Diode, $\lambda_{paste}=2.5\text{ W}/(\text{mK})$			1	K/W
<b>Module</b>					
$L_{CE}$				30	nH
$M_s$	to heat sink		2	2.5	Nm
$w$				55	g
<b>Temperature Sensor</b>					
$R_{100}$	$T_r=100^\circ\text{C}$ ( $R_{25}=1000\Omega$ )			$1670 \pm 3\%$	Ω
$R_{(T)}$	$R_{(T)}=1000\Omega[1+A(T-25^\circ\text{C})+B(T-25^\circ\text{C})^2]$ , $A = 7.635 \cdot 10^{-3} \text{ }^\circ\text{C}^{-1}$ , $B = 1.731 \cdot 10^{-5} \text{ }^\circ\text{C}^{-2}$				



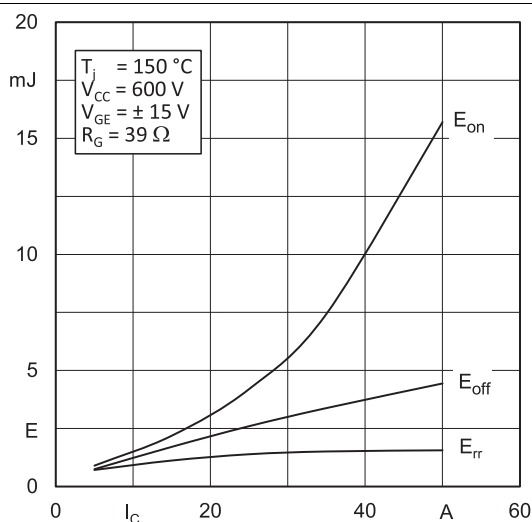
ACC



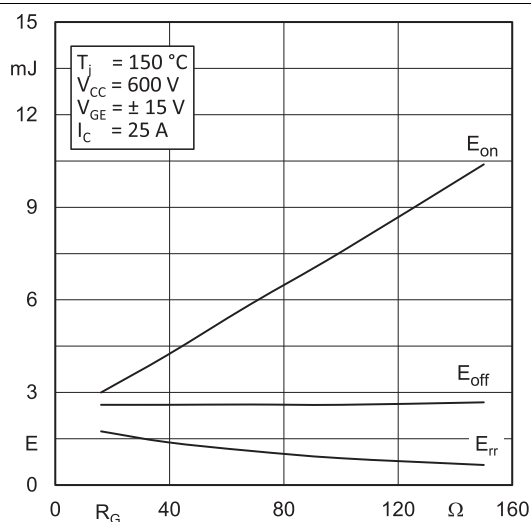
IGBT 1-6 - Fig. 1:  
Typ. output characteristic



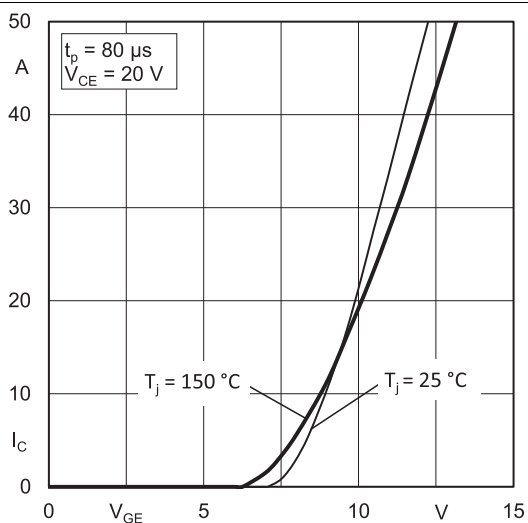
IGBT 1-6 - Fig. 2:  
Typ. rated current vs. temperature  $I_C = f(T_s)$



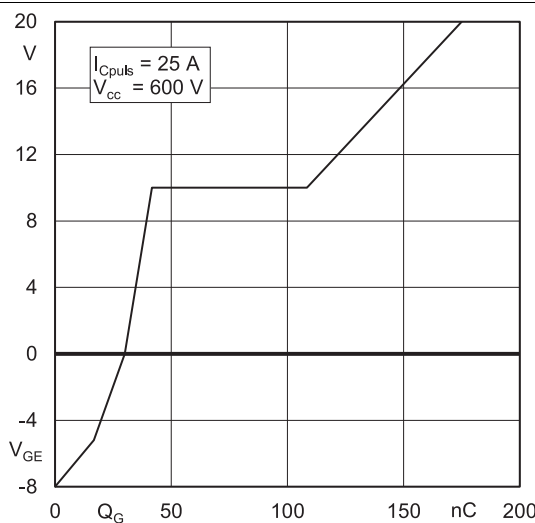
IGBT 1-6 - Fig. 3:  
Typ. turn-on /-off energy =  $f(I_C)$



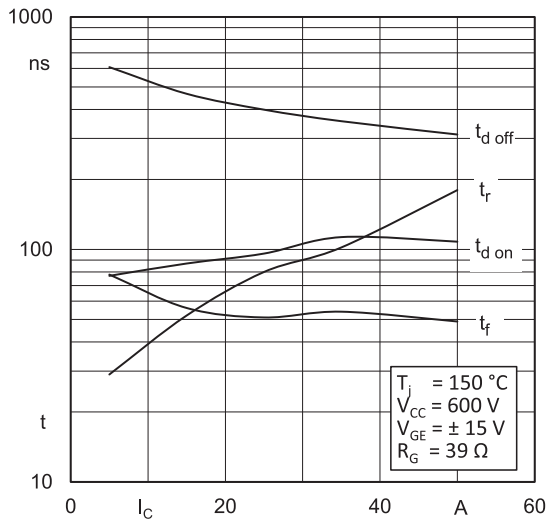
IGBT 1-6 - Fig. 4:  
Typ. turn-on /-off energy =  $f(R_G)$



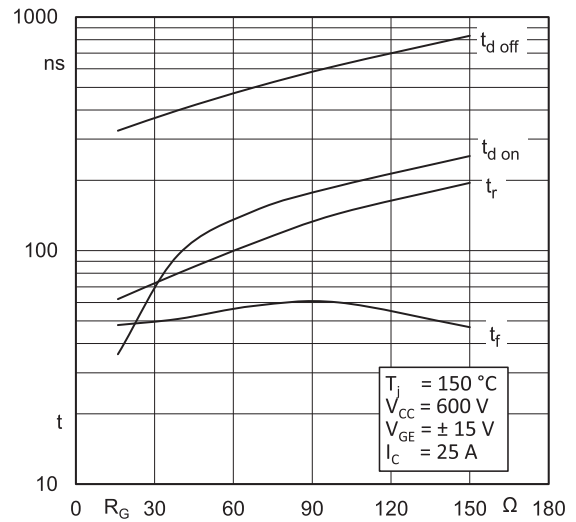
IGBT 1-6 - Fig. 5:  
Typ. transfer characteristic



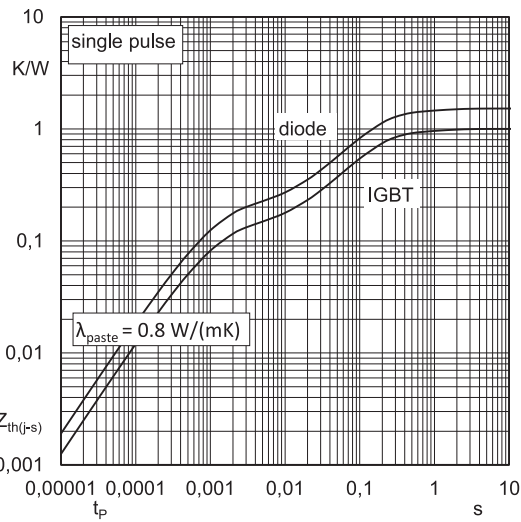
IGBT 1-6 - Fig. 6:  
Typ. gate charge characteristic



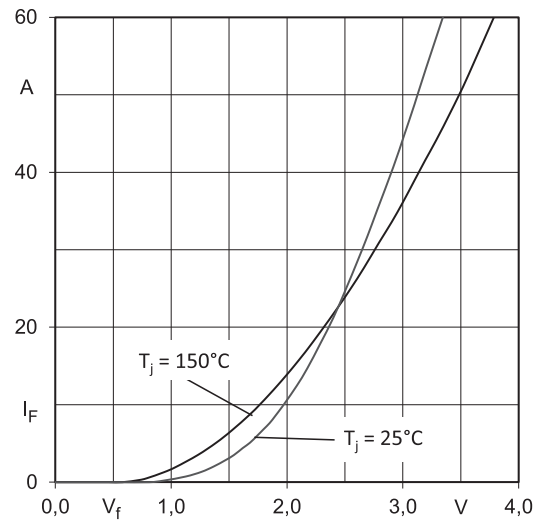
IGBT 1-6 - Fig. 7:  
Typ. switching times vs.  $I_C$



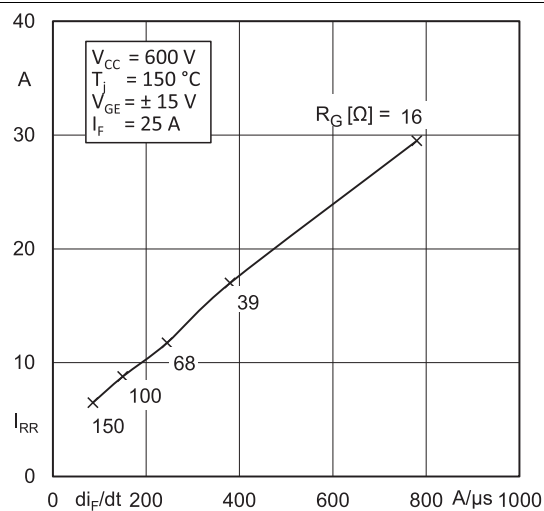
IGBT 1-6 - Fig. 8:  
Typ. switching times vs. gate resistor  $R_G$



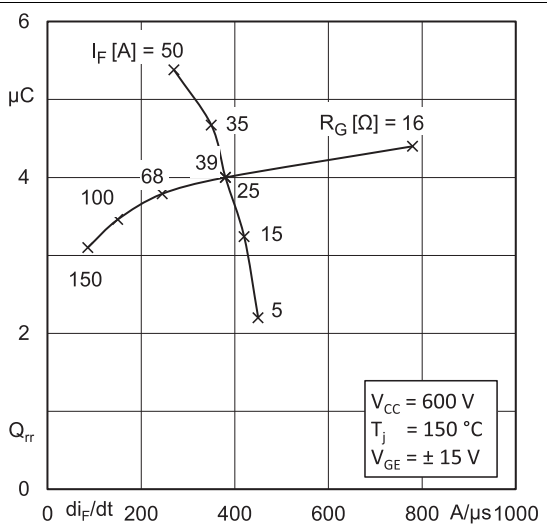
IGBT 1-6 - Fig. 9:  
Transient thermal impedance of IGBT and Diode



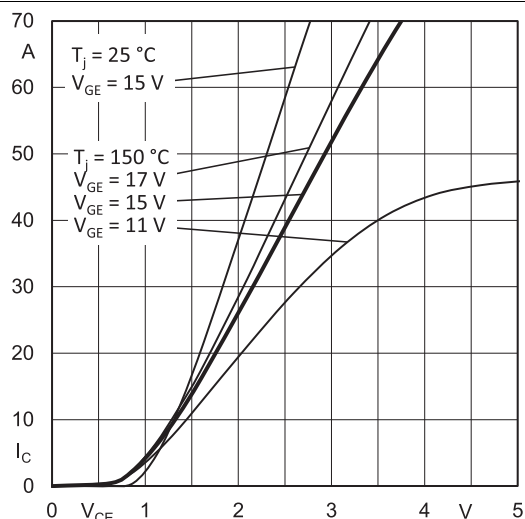
IGBT 1-6 - Fig. 10:  
CAL diode forward characteristic



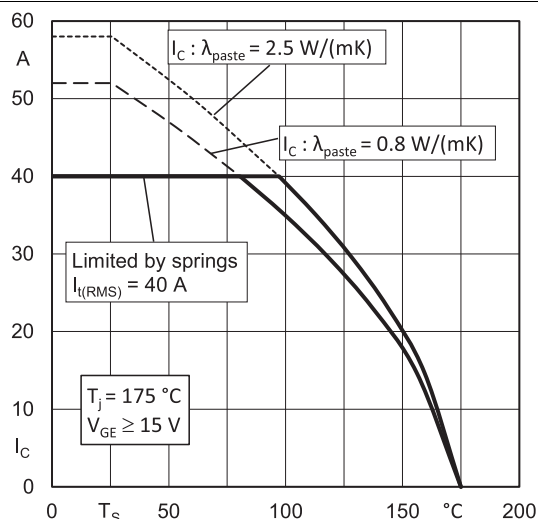
IGBT 1-6 - Fig. 11:  
Typ. CAL diode peak reverse recovery current



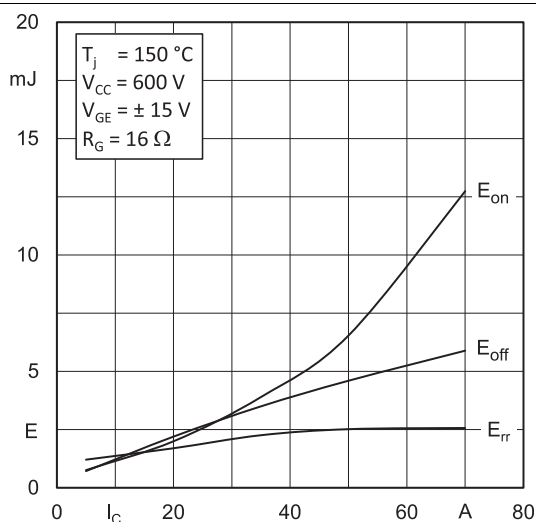
IGBT 1-6 - Fig. 12:  
Typ. CAL diode recovery charge



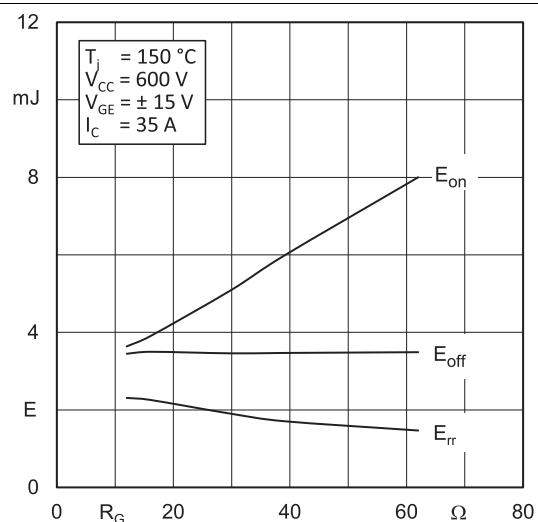
IGBT 7-12 - Fig. 1:  
Typ. output characteristic



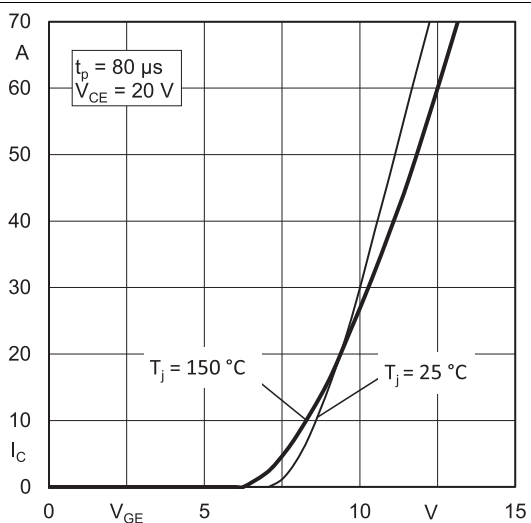
IGBT 7-12 - Fig. 2:  
Typ. rated current vs. temperature  $I_C = f(T_S)$



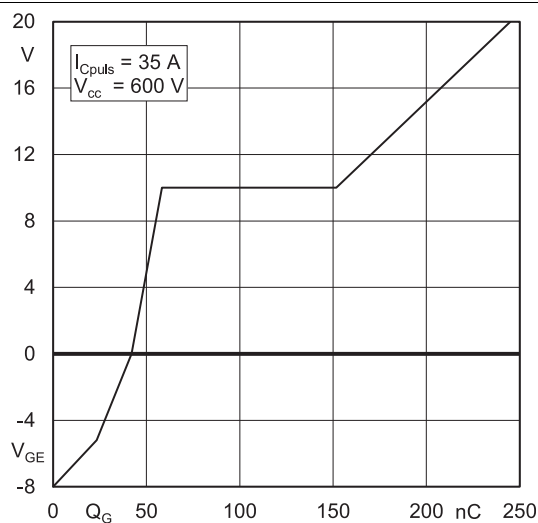
IGBT 7-12 - Fig. 3:  
Typ. turn-on /-off energy =  $f(I_C)$



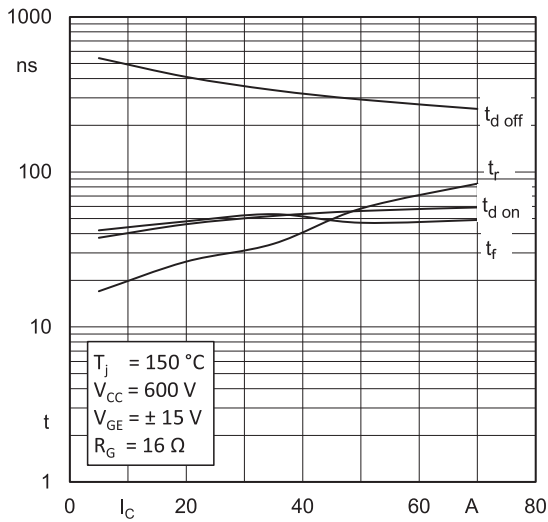
IGBT 7-12 - Fig. 4:  
Typ. turn-on / -off energy =  $f(R_G)$



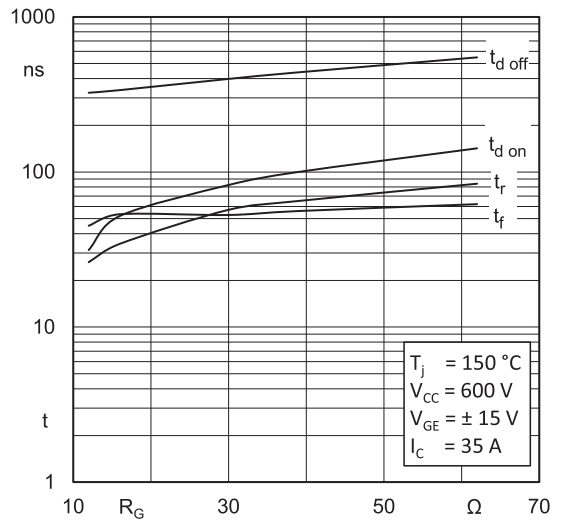
IGBT 7-12 - Fig. 5:  
Typ. transfer characteristic



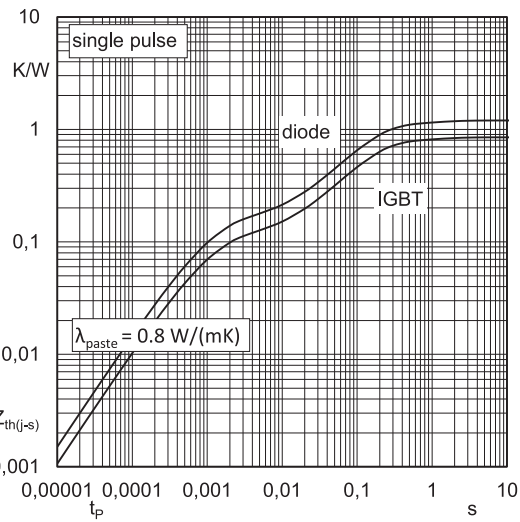
IGBT 7-12 - Fig. 6:  
Typ. gate charge characteristic



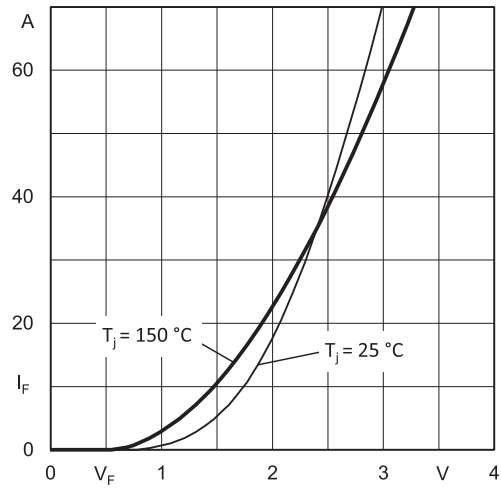
IGBT 7-12 - Fig. 7:  
Typ. switching times vs.  $I_C$



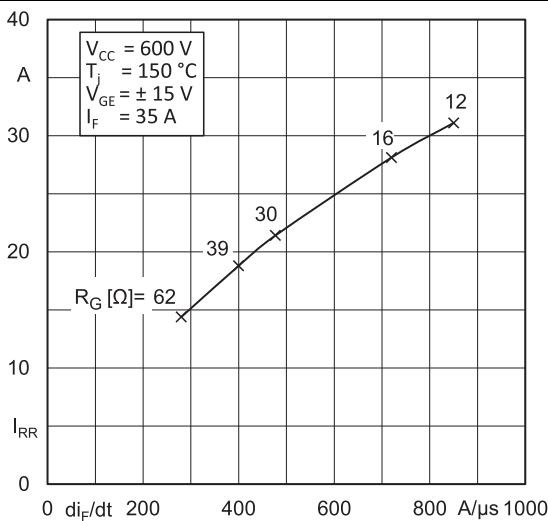
IGBT 7-12 - Fig. 8:  
Typ. switching times vs. gate resistor  $R_G$



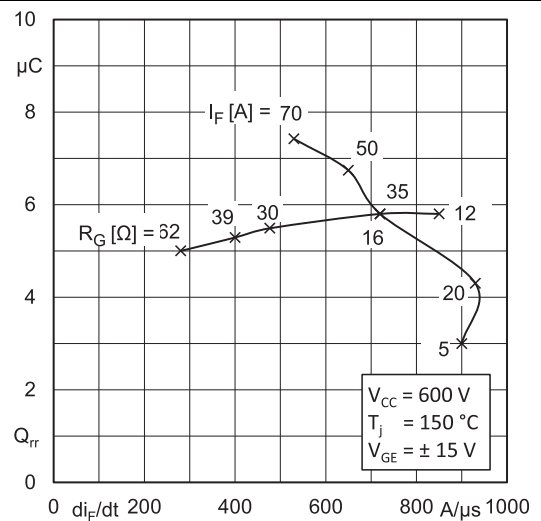
IGBT 7-12 - Fig. 9:  
Transient thermal impedance of IGBT and Diode



IGBT 7-12 - Fig. 10:  
CAL diode forward characteristic



IGBT 7-12 - Fig. 11:  
Typ. CAL diode peak reverse recovery current



IGBT 7-12 - Fig. 12:  
Typ. CAL diode recovery charge





This is an electrostatic discharge sensitive device (ESDS) due to international standard IEC 61340.

## **\*IMPORTANT INFORMATION AND WARNINGS**

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